

# FDMC2523P

## P-Channel QFET®

-150V, -3A, 1.5Ω

### Features

- Max  $r_{DS(on)}$  = 1.5Ω at  $V_{GS} = -10V$ ,  $I_D = -1.5A$
- Low  $C_{rss}$  ( typical 10pF)
- Fast Switching
- Low gate charge ( typical 6.2 nC )
- Improved dv / dt capability
- RoHS Compliant

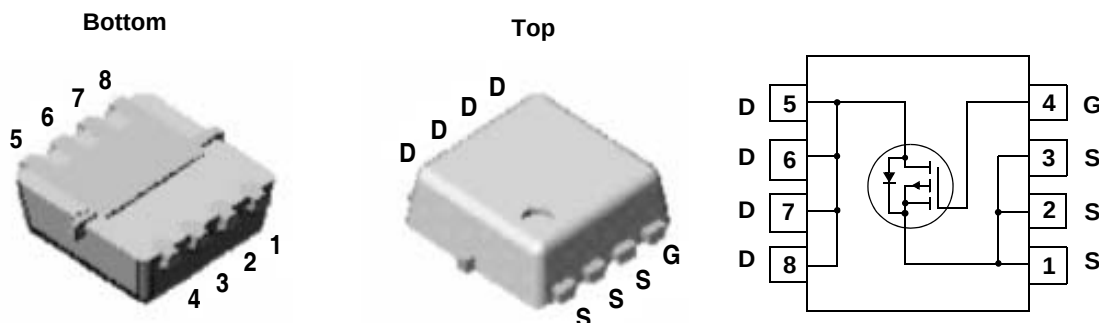


### General Description

These P-Channel MOSFET enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC/DC converters, and DC motor control.

### Application

- Active Clamp Switch



Power 33

### MOSFET Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

| Symbol         | Parameter                                                                     | Ratings     | Units |
|----------------|-------------------------------------------------------------------------------|-------------|-------|
| $V_{DS}$       | Drain to Source Voltage                                                       | -150        | V     |
| $V_{GS}$       | Gate to Source Voltage                                                        | ±30         | V     |
| $I_D$          | Drain Current -Continuous $T_C = 25^\circ C$                                  | -3          | A     |
|                | -Continuous $T_C = 100^\circ C$                                               | -1.8        |       |
|                | -Pulsed                                                                       | -12         |       |
| $P_D$          | Power Dissipation (Steady State) $T_C = 25^\circ C$                           | 42          | W     |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range                              | -55 to +150 | °C    |
| $T_L$          | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | 300         | °C    |
| dv/dt          | Peak Diode Recovery dv/dt (Note 2)                                            | -5          | V/ns  |

### Thermal Characteristics

|                 |                                                   |     |      |
|-----------------|---------------------------------------------------|-----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case (Note 1)     | 3.0 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 60  |      |

### Package Marking and Ordering Information

| Device Marking | Device    | Package  | Reel Size | Tape Width | Quantity   |
|----------------|-----------|----------|-----------|------------|------------|
| FDMC2523P      | FDMC2523P | Power 33 | 7"        | 8mm        | 3000 units |

**Electrical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|                                      |                                           |                                                                             |      |      |           |                      |
|--------------------------------------|-------------------------------------------|-----------------------------------------------------------------------------|------|------|-----------|----------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = -250\mu\text{A}$ , $V_{GS} = 0\text{V}$                              | -150 |      |           | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$                  |      | -138 |           | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = -150\text{V}$ , $V_{GS} = 0\text{V}$<br>$T_J = 125^\circ\text{C}$ |      |      | -1<br>-10 | $\mu\text{A}$        |
| $I_{GSS}$                            | Gate to Source Leakage Current            | $V_{GS} = \pm 30\text{V}$ , $V_{DS} = 0\text{V}$                            |      |      | $\pm 100$ | nA                   |

**On Characteristics**

|                                        |                                                          |                                                                                                                            |    |            |            |                      |
|----------------------------------------|----------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------|----|------------|------------|----------------------|
| $V_{GS(th)}$                           | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}$ , $I_D = -250\mu\text{A}$                                                                                | -3 | -3.8       | -5         | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$                                                                 |    | 6          |            | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$                           | Static Drain to Source On Resistance                     | $V_{GS} = -10\text{V}$ , $I_D = -1.5\text{A}$<br>$V_{GS} = -10\text{V}$ , $I_D = -1.5\text{A}$ , $T_J = 125^\circ\text{C}$ |    | 1.1<br>2.0 | 1.5<br>3.6 | $\Omega$             |
| $g_{FS}$                               | Forward Transconductance                                 | $V_{DS} = -40\text{V}$ , $I_D = -1.5\text{A}$ (Note 4)                                                                     |    | 1.4        |            | S                    |

**Dynamic Characteristics**

|           |                              |                                                                      |  |     |     |          |
|-----------|------------------------------|----------------------------------------------------------------------|--|-----|-----|----------|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = -25\text{V}$ , $V_{GS} = 0\text{V}$ ,<br>$f = 1\text{MHz}$ |  | 200 | 270 | pF       |
| $C_{oss}$ | Output Capacitance           |                                                                      |  | 60  | 80  | pF       |
| $C_{rss}$ | Reverse Transfer Capacitance |                                                                      |  | 10  | 15  | pF       |
| $R_g$     | Gate Resistance              | $f = 1\text{MHz}$                                                    |  | 7.5 |     | $\Omega$ |

**Switching Characteristics**

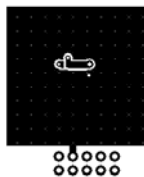
|              |                               |                                                                                                            |  |     |    |    |
|--------------|-------------------------------|------------------------------------------------------------------------------------------------------------|--|-----|----|----|
| $t_{d(on)}$  | Turn-On Delay Time            | $V_{DD} = -75\text{V}$ , $I_D = -3\text{A}$<br>$V_{GS} = -10\text{V}$ , $R_{GEN} = 25\Omega$<br>(Note 3,4) |  | 15  | 27 | ns |
| $t_r$        | Rise Time                     |                                                                                                            |  | 11  | 20 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time           |                                                                                                            |  | 19  | 35 | ns |
| $t_f$        | Fall Time                     |                                                                                                            |  | 13  | 24 | ns |
| $Q_g$        | Total Gate Charge             | $V_{GS} = -10\text{V}$                                                                                     |  | 6.2 | 9  | nC |
| $Q_{gs}$     | Gate to Source Gate Charge    | $V_{DD} = -75\text{V}$<br>$I_D = -3\text{A}$                                                               |  | 1.4 |    | nC |
| $Q_{gd}$     | Gate to Drain "Miller" Charge | (Note 3,4)                                                                                                 |  | 3.3 |    | nC |

**Drain-Source Diode Characteristics**

|                 |                                                         |                                                     |  |  |      |    |    |
|-----------------|---------------------------------------------------------|-----------------------------------------------------|--|--|------|----|----|
| I <sub>S</sub>  | Maximum continuous Drain - Source Diode Forward Current |                                                     |  |  | -3   | A  |    |
| I <sub>SM</sub> | Maximum Pulse Drain - Source Diode Forward Current      |                                                     |  |  | -12  | A  |    |
| V <sub>SD</sub> | Source to Drain Diode Forward Voltage                   | V <sub>GS</sub> = 0V, I <sub>S</sub> = -3.0A        |  |  | -1.8 | -5 | V  |
| t <sub>rr</sub> | Reverse Recovery Time                                   | I <sub>F</sub> = -3.0A, di/dt = 100A/μs<br>(Note 3) |  |  | 93   |    | ns |
| Q <sub>rr</sub> | Reverse Recovery Charge                                 |                                                     |  |  | 0.27 |    | nC |

**Notes:**

1:  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $60^\circ\text{C}/\text{W}$  when mounted on a  $1\text{in}^2$  pad of 2 oz copper



b.  $135^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper

2:  $I_{SD} \leq -3\text{A}$ ,  $di/dt \leq 300\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$

3: Pulse Test: Pulse Width  $< 300\mu\text{s}$ , Duty cycle  $< 2.0\%$ .

4: Essentially independent of operating temperature.

## Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

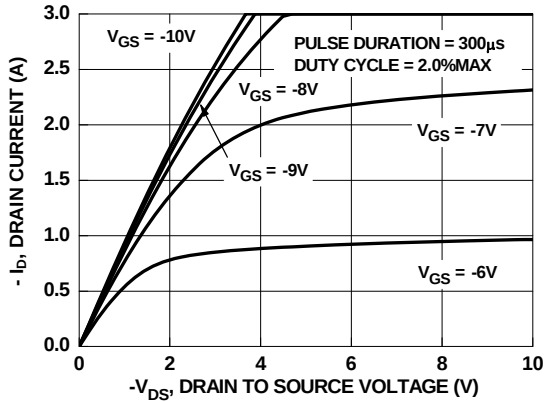


Figure 1. On-Region Characteristics

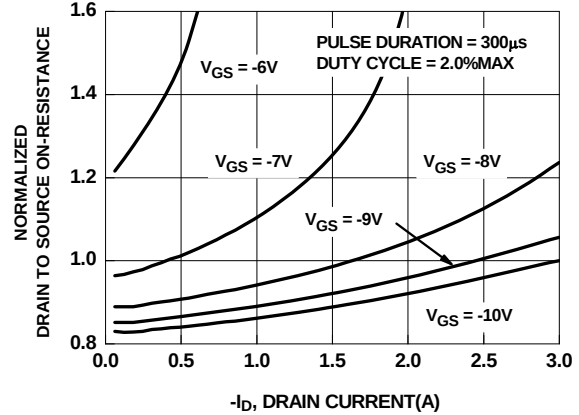


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

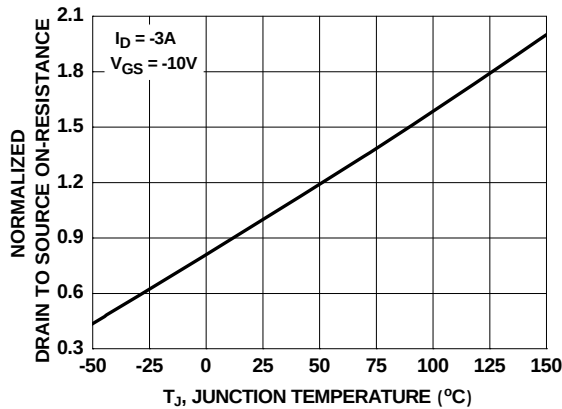


Figure 3. Normalized On-Resistance vs Junction Temperature

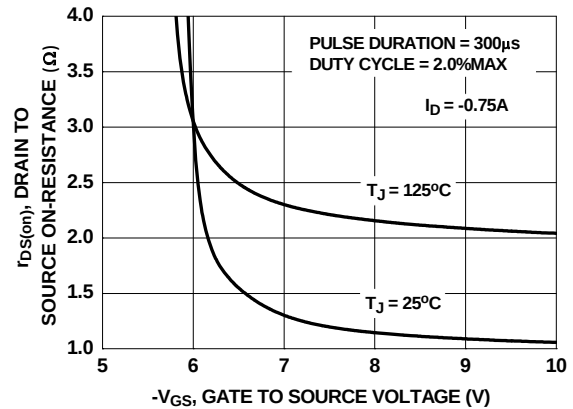


Figure 4. On-Resistance vs Gate to Source Voltage

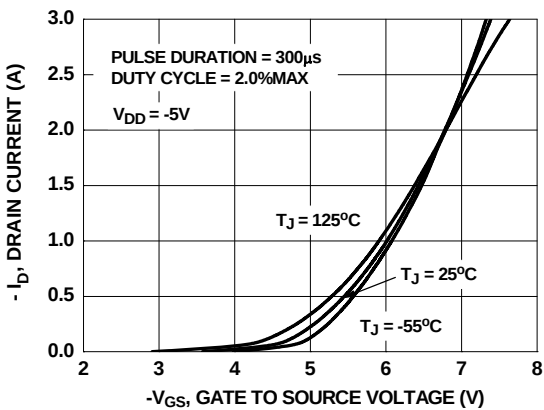


Figure 5. Transfer Characteristics

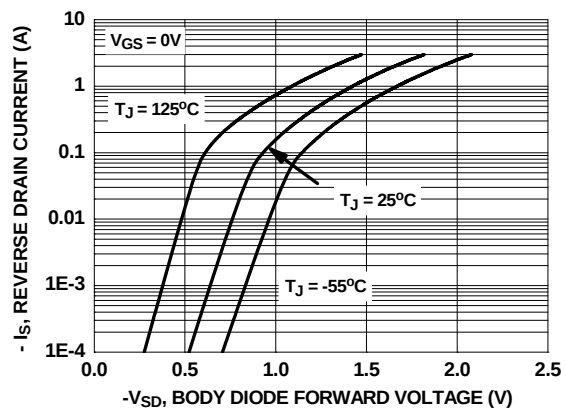


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

# Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

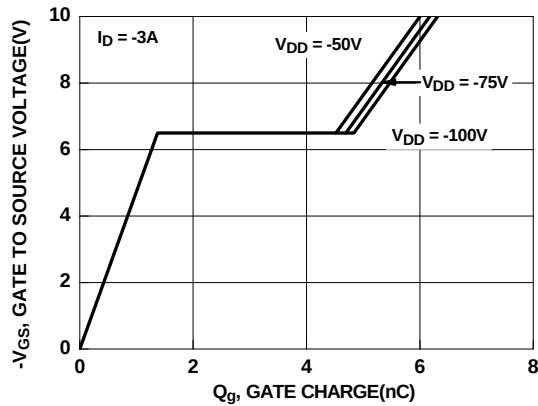


Figure 7. Gate Charge Characteristics

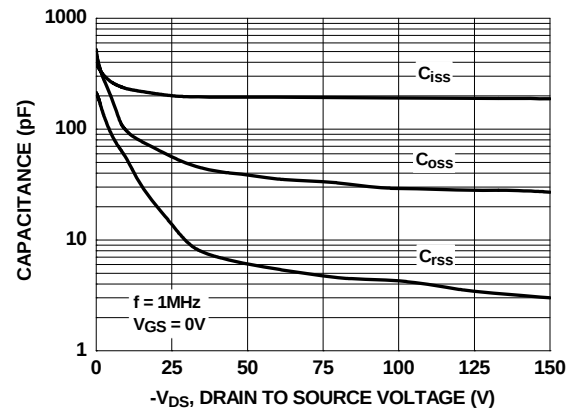


Figure 8. Capacitance vs Drain to Source Voltage

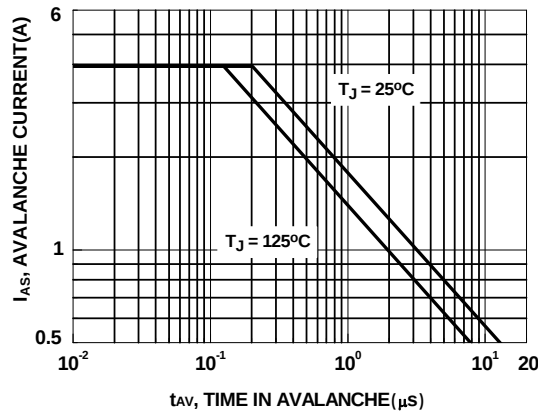


Figure 9. Unclamped Inductive Switching Capability

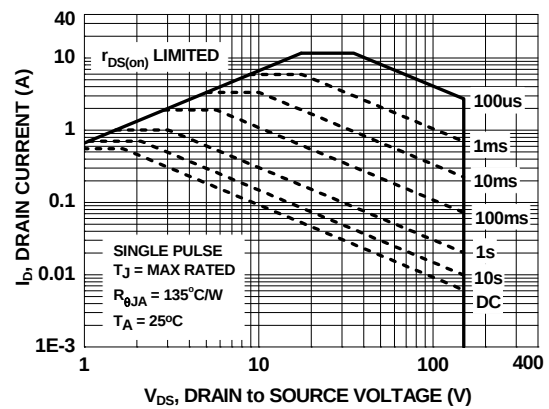


Figure 10. Forward Bias Safe Operating Area

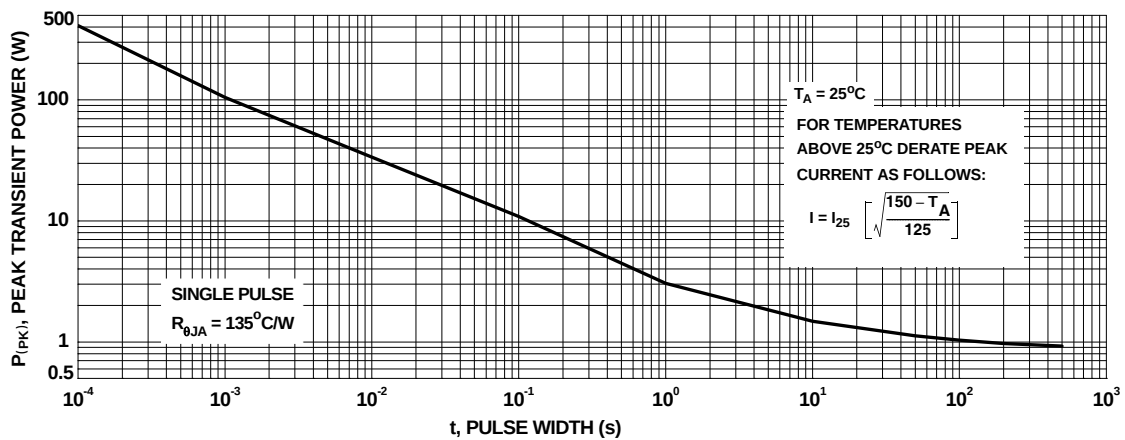
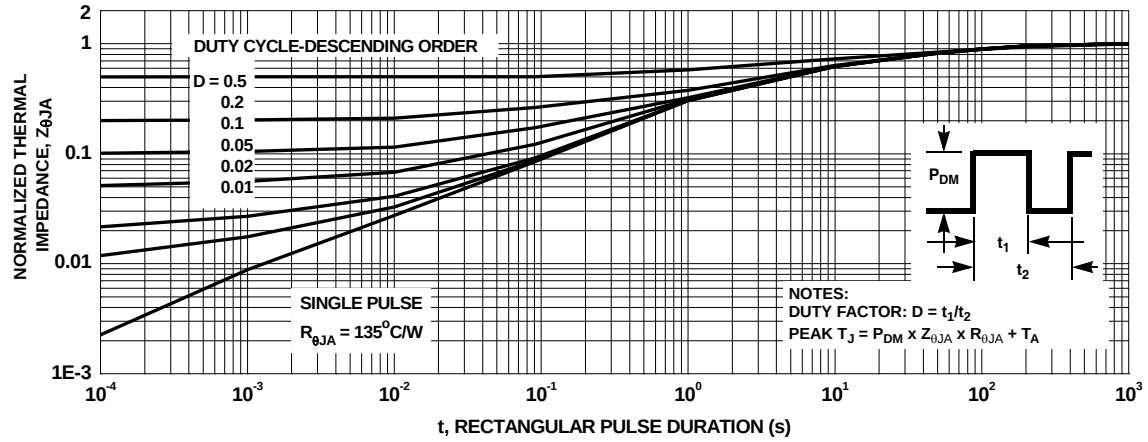
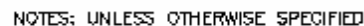


Figure 11. Single Pulse Maximum Power Dissipation

# Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted





- A) NO PACKAGE STANDARD REFERENCE  
AS OF 29 JUNE 2002.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.  
DIMENSIONS DO NOT INCLUDE BURRS  
OR MOLD FLASH.
- D) DIMENSIONING AND TOLERANCING PER  
ASME Y14.5M-1994.

## TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

|                                      |                     |                     |                  |         |
|--------------------------------------|---------------------|---------------------|------------------|---------|
| ACEx™                                | FACT Quiet Series™  | OCX™                | SILENT SWITCHER® | UniFET™ |
| ActiveArray™                         | GlobalOptoisolator™ | OCXPro™             | SMART START™     | VCX™    |
| Bottomless™                          | GTO™                | OPTOLOGIC®          | SPM™             | Wire™   |
| Build it Now™                        | HiSeC™              | OPTOPLANAR™         | Stealth™         |         |
| CoolFET™                             | I <sup>2</sup> C™   | PACMAN™             | SuperFET™        |         |
| CROSSVOLT™                           | i-Lo™               | POP™                | SuperSOT™-3      |         |
| DOMET™                               | ImpliedDisconnect™  | Power247™           | SuperSOT™-6      |         |
| EcoSPARK™                            | IntelliMAX™         | PowerEdge™          | SuperSOT™-8      |         |
| E <sup>2</sup> CMOS™                 | ISOPLANAR™          | PowerSaver™         | SyncFET™         |         |
| EnSigna™                             | LittleFET™          | PowerTrench®        | TCM™             |         |
| FACT®                                | MICROCOUPLER™       | QFET®               | TinyBoost™       |         |
| FAST®                                | MicroFET™           | QS™                 | TinyBuck™        |         |
| FASTr™                               | MicroPak™           | QT Optoelectronics™ | TinyPWM™         |         |
| FPS™                                 | MICROWIRE™          | Quiet Series™       | TinyPower™       |         |
| FRFET™                               | MSX™                | RapidConfigure™     | TinyLogic®       |         |
|                                      | MSXPro™             | RapidConnect™       | TINYOPTO™        |         |
|                                      |                     | µSerDes™            | TruTranslation™  |         |
|                                      |                     | ScalarPump™         | UHC®             |         |
| Across the board. Around the world.™ |                     |                     |                  |         |
| The Power Franchise®                 |                     |                     |                  |         |
| Programmable Active Droop™           |                     |                     |                  |         |

## DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

## LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

## PRODUCT STATUS DEFINITIONS

### Definition of Terms

| Datasheet Identification | Product Status         | Definition                                                                                                                                                                                                            |
|--------------------------|------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Advance Information      | Formative or In Design | This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.                                                                                    |
| Preliminary              | First Production       | This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design. |
| No Identification Needed | Full Production        | This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.                                                       |
| Obsolete                 | Not In Production      | This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.                                                   |

Rev. I22